



Silicon N-Channel Power MOSFET

CS120N08 A0



General Description:

CS120N08 A0, the silicon N-channel Enhanced VDMOSFETs, is obtained by advanced Trench Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is TO-263, which accords with the RoHS standard.

Features:

- Fast Switching
- Low ON Resistance($R_{DS(on)} \leq 7.5\text{m}\Omega$)
- Low Gate Charge (Typical Data: 74.4nC)
- Low Reverse transfer capacitances(Typical: 253pF)
- 100% Single Pulse avalanche energy Test

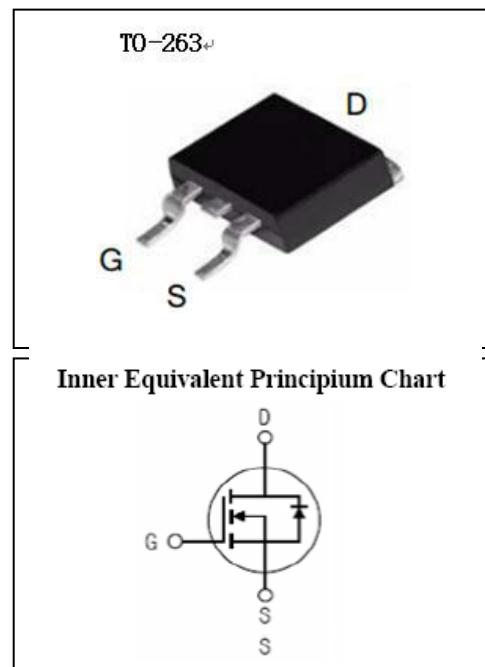
Applications:

Power switch circuit of adaptor and charger.

Absolute ($T_c = 25^\circ\text{C}$ unless otherwise specified):

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-to-Source Voltage	85	V
I_D	Continuous Drain Current	120	A
	Continuous Drain Current $T_c = 100^\circ\text{C}$	85	A
I_{DM}^{a1}	Pulsed Drain Current	480	A
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}^{a2}	Single Pulse Avalanche Energy	650.25	mJ
P_D	Power Dissipation	208	W
	Derating Factor above 25 °C	1.6	W/°C
T_J, T_{stg}	Operating Junction and Storage Temperature Range	150, -55 to 150	°C
T_L	Maximum Temperature for Soldering	300	°C

V_{DSS}	85	V
I_D (Silicon limited current)	120	A
$P_D(T_c=25^\circ\text{C})$	208	W
$R_{DS(ON)}^{\text{Typ}}$	6	$\text{m}\Omega$



**Electrical Characteristics** (T_c= 25°C unless otherwise specified):

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V _{DSS}	Drain to Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	85	--	--	V
I _{DSS}	Drain to Source Leakage Current	V _{DS} =85V, V _{GS} =0V, T _a = 25 °C	--	--	1	μA
		V _{DS} =68V, V _{GS} =0V, T _a = 100 °C	--	--	100	μA
I _{GSS(F)}	Gate to Source Forward Leakage	V _{GS} =+20V	--	--	100	nA
I _{GSS(R)}	Gate to Source Reverse Leakage	V _{GS} =-20V	--	--	-100	nA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
R _{DS(ON)}	Drain-to-Source On-Resistance	V _{GS} =10V, I _D =60A	--	6.0	7.5	mΩ
V _{GS(TH)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA	2.0	--	4.0	V
Pulse width t _p ≤300 μs, δ ≤2%						

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =25V f=1.0MHz	--	4572	--	pF
C _{oss}	Output Capacitance		--	494.4	--	
C _{rss}	Reverse Transfer Capacitance		--	253	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
t _{d(ON)}	Turn-on Delay Time	V _{GS} =10V, RG=6Ω V _{DD} =40V, ID=60A	--	35.7	--	ns
tr	Rise Time		--	65.6	--	
t _{d(OFF)}	Turn-Off Delay Time		--	67.2	--	
t _f	Fall Time		--	21.87	--	
Q _g	Total Gate Charge	V _{GS} =10V, V _{DD} =64V ID=60A	--	74.4	--	nC
Q _{gs}	Gate to Source Charge		--	21.9	--	
Q _{gd}	Gate to Drain ("Miller")Charge		--	22.4	--	

**Source-Drain Diode Characteristics**

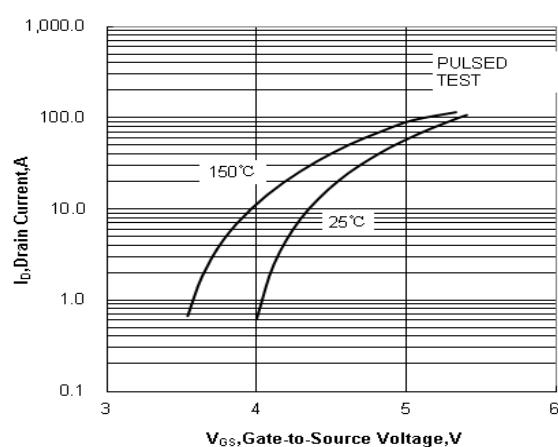
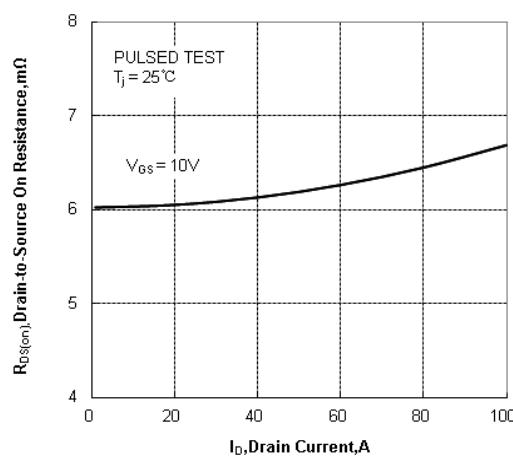
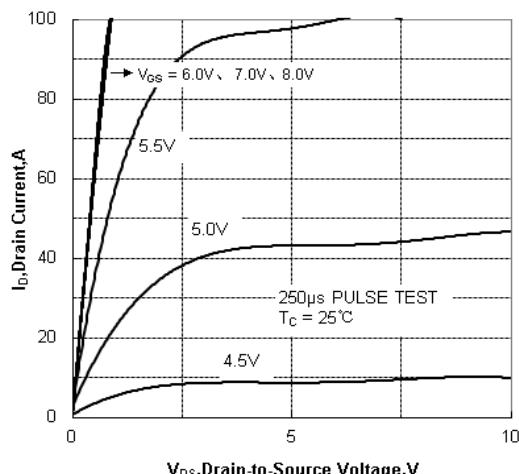
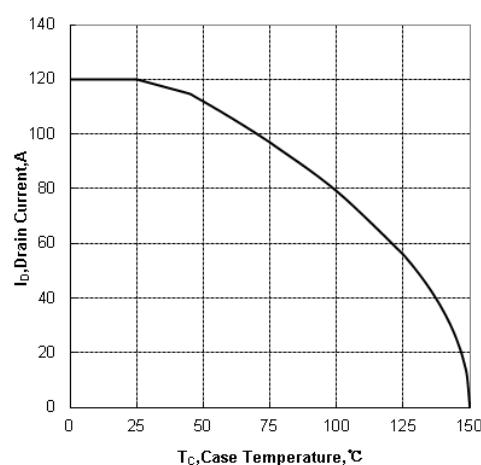
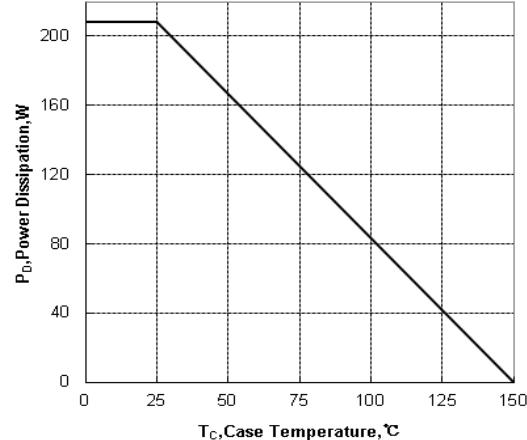
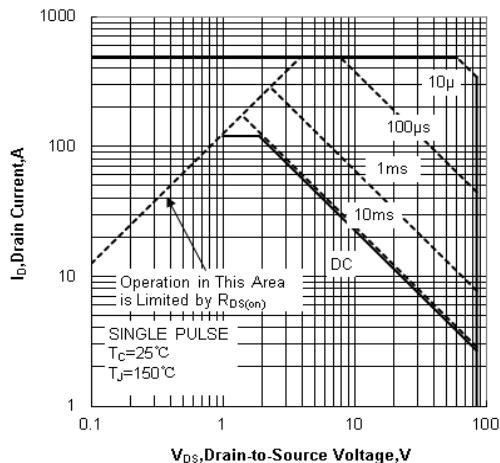
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I _S	Continuous Source Current (Body Diode)		--	--	120	A
I _{SM}	Maximum Pulsed Current (Body Diode)		--	--	480	A
V _{SD}	Diode Forward Voltage	I _S =60A, V _{GS} =0V	--	--	1.2	V
trr	Reverse Recovery Time	I _S =20A, T _j = 25 °C dI _F /dt=100A/us, V _{GS} =0V	--	72	--	ns
Qrr	Reverse Recovery Charge		--	126	--	nC
I _{RRM}	Reverse Recovery Current		--	3.5	--	A

Pulse width t_p≤300μs, δ ≤2%

Symbol	Parameter	Max.	Units
R _{θ JC}	Junction-to-Case	0.517	°C/W
R _{θ JA}	Junction-to-Ambient	62.5	°C/W

^{a1}: Repetitive rating; pulse width limited by maximum junction temperature^{a2}: L=0.5mH, I_D=51A, Start T_j=25°C

Characteristics Curve:



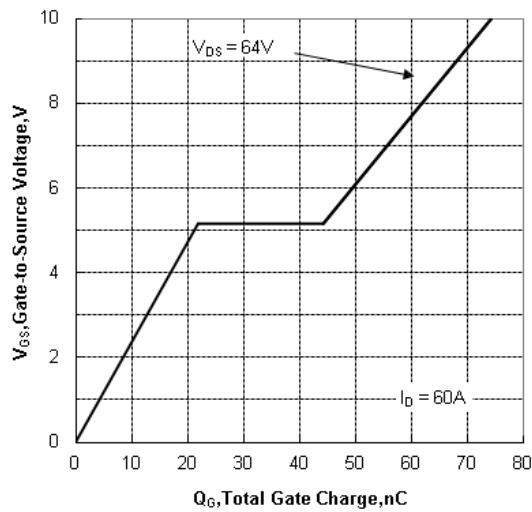


Figure 7 Typical Gate Charge vs Gate to Source Voltage

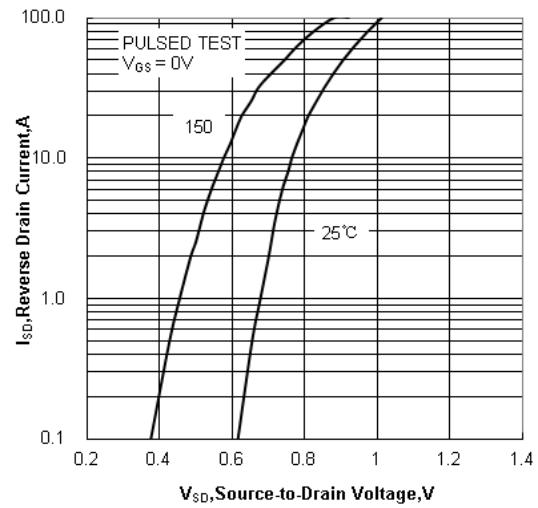


Figure 8 Typical Body Diode Transfer Characteristics

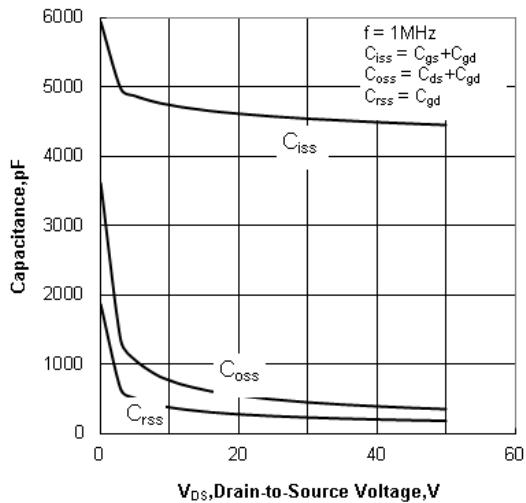


Figure 9 Typical Capacitance vs Drain to Source Voltage

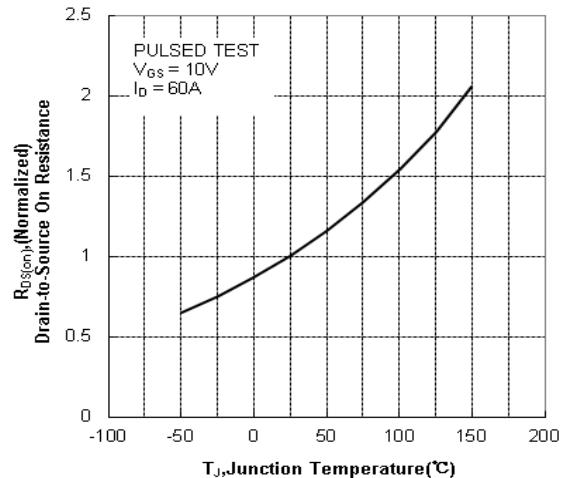


Figure 10 Typical Drian to Source on Resistance vs Junction Temperature

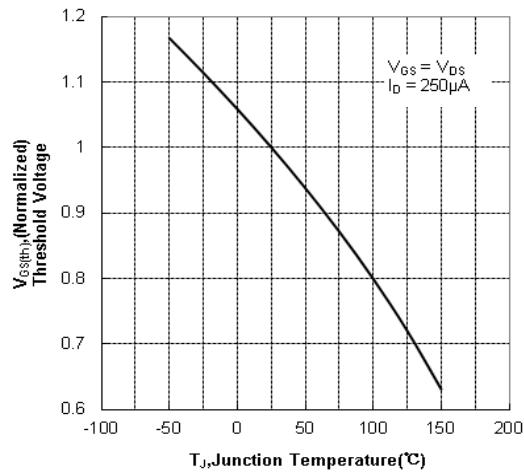


Figure 11 Typical Threshold Voltage vs Junction Temperature

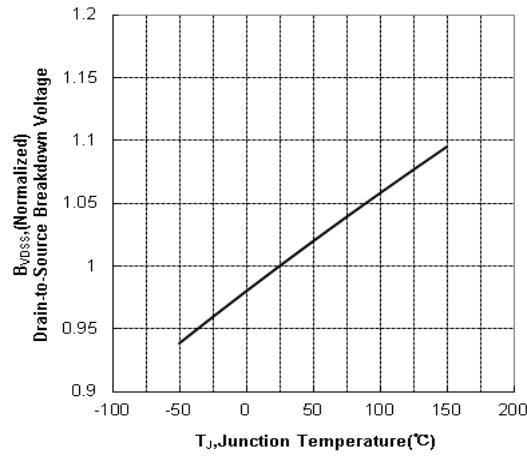


Figure 12 Typical Breakdown Voltage vs Junction Temperature

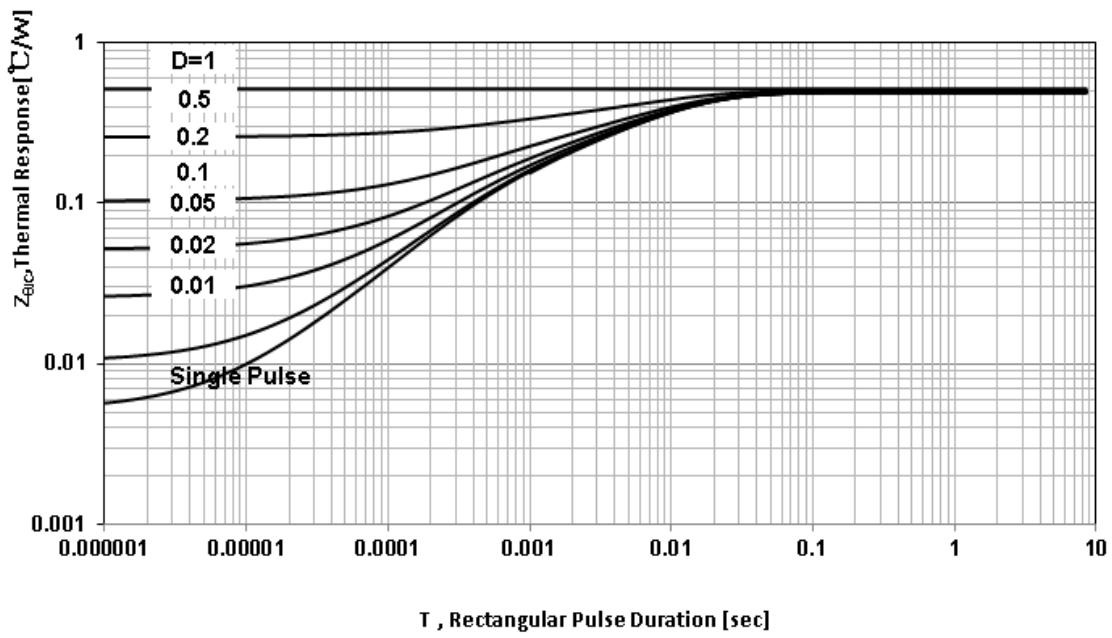


Figure 13 Maximum Effective Transient Thermal Impedance, Junction-to-Case

Test Circuit and Waveform

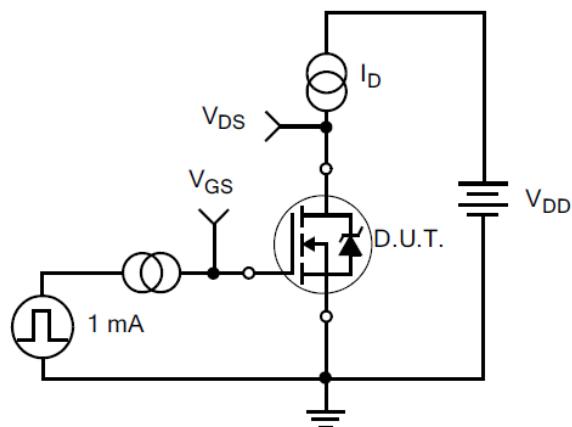


Figure 17. Gate Charge Test Circuit

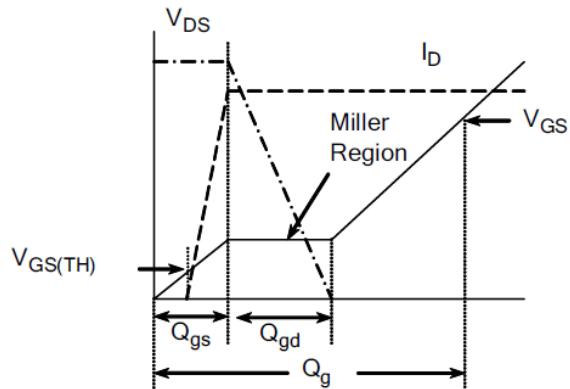


Figure 18. Gate Charge Waveform

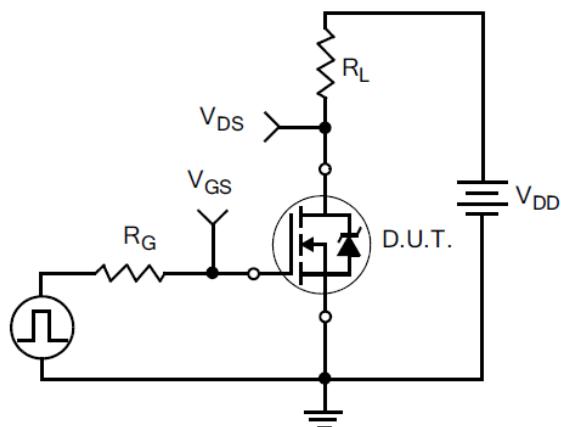


Figure 19. Resistive Switching Test Circuit

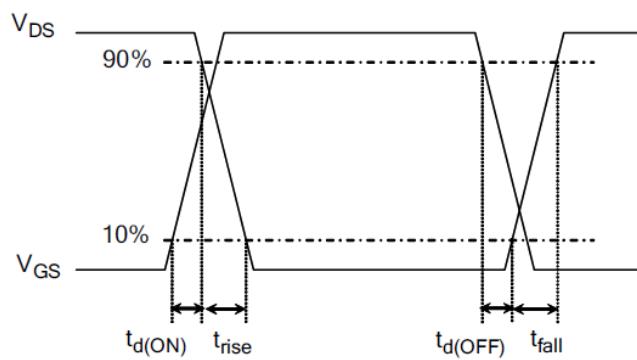


Figure 20. Resistive Switching Waveforms

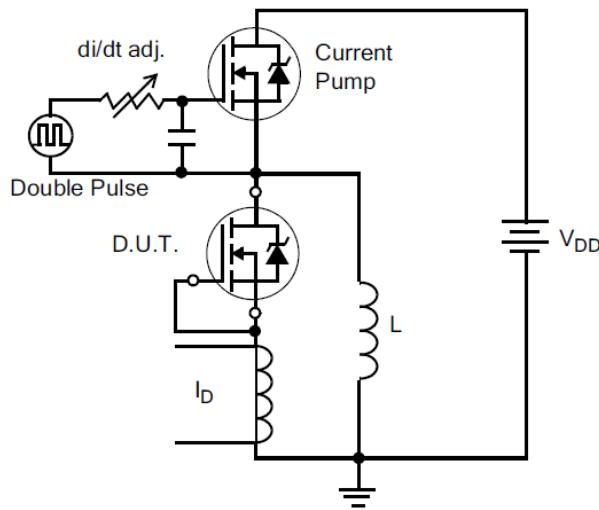


Figure 21. Diode Reverse Recovery Test Circuit

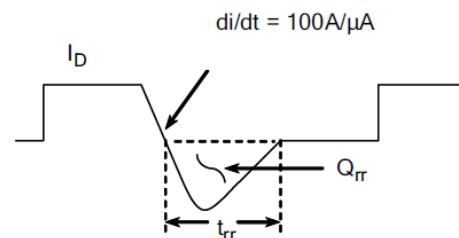


Figure 22. Diode Reverse Recovery Waveform

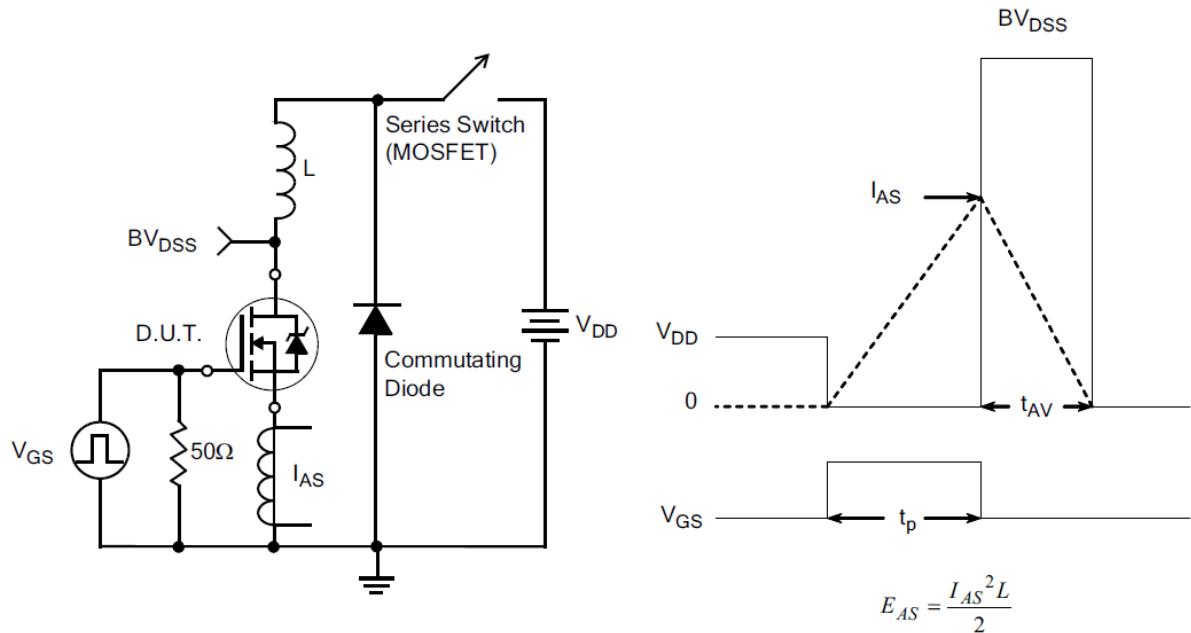


Figure 23. Unclamped Inductive Switching Test Circuit

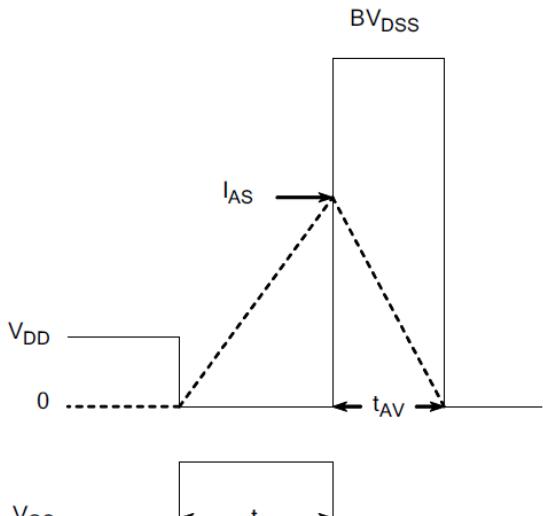
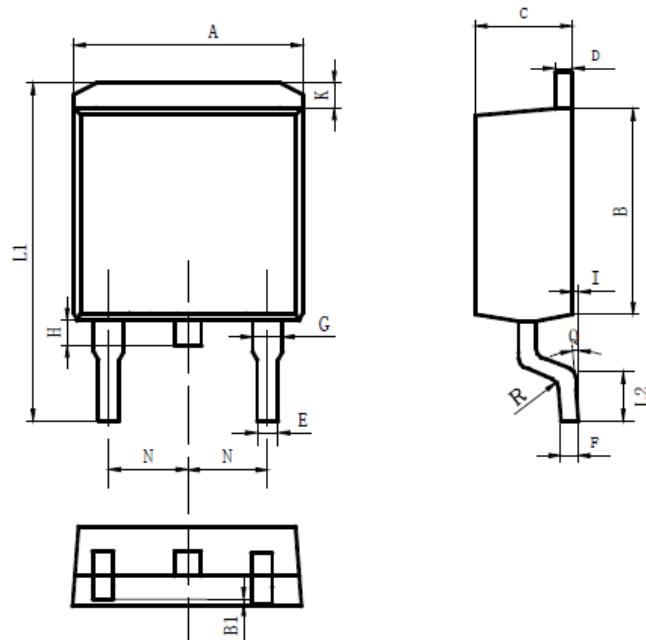


Figure 24. Unclamped Inductive Switching Waveforms

Package Information:



Items	Values(mm)	
	MIN	MAX
A	9.80	10.40
B	8.90	9.50
B1	0	0.10
C	4.40	4.80
D	1.16	1.37
E	0.70	0.95
F	0.30	0.60
G	1.07	1.47
H	1.30	1.80
K	0.95	1.37
L1	14.50	16.50
L2	1.60	2.30
I	0	0.2
Q	0°	8°
R	0.4	
N	2.39	2.69

TO-263 Package



The name and content of poisonous and harmful material in products

Warnings

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. It is suggested to be used under 80 percent of the maximum ratings of the device.
 2. When installing the heatsink, please pay attention to the torsional moment and the smoothness of the heatsink.
 3. VDMOSFETs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
 4. This publication is made by Huajing Microelectronics and subject to regular change without notice.

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